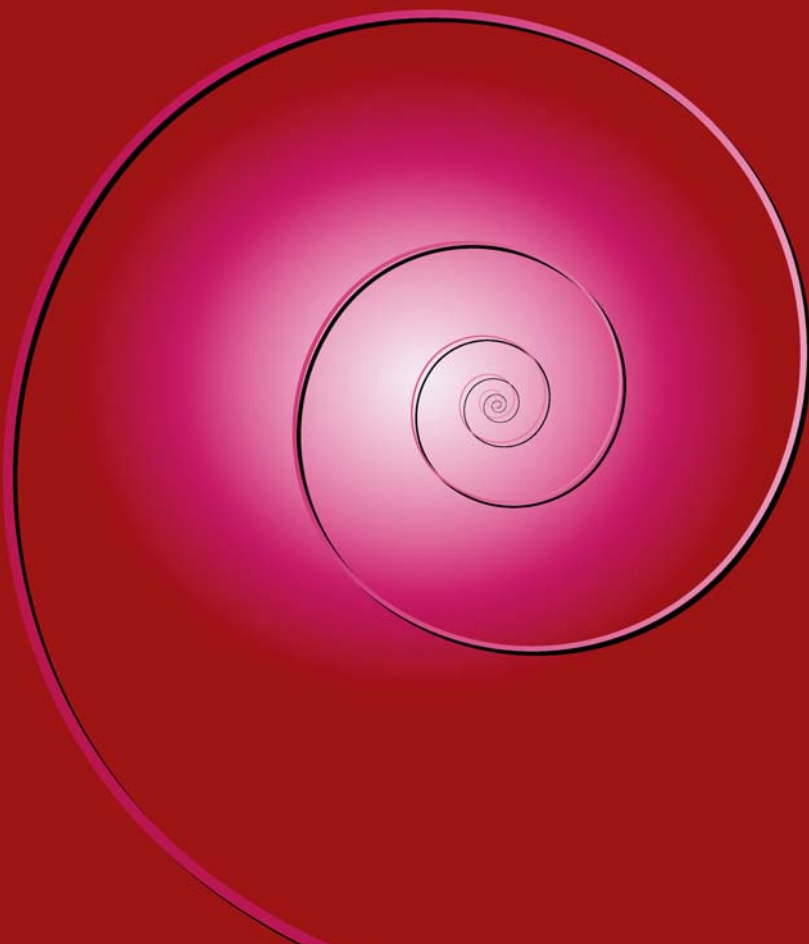

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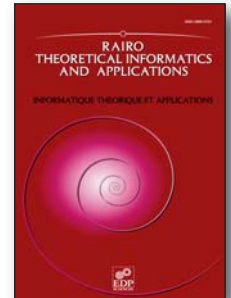
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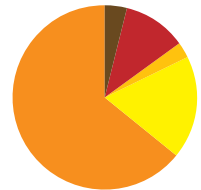
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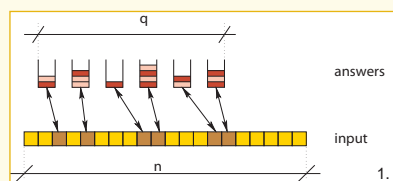
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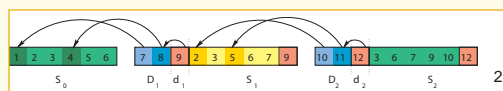
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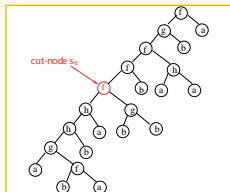


1- Communication pattern mapped to input.



2- An example of first two frames for $K = 3$, i.e. with buffer of size 6. The arrows indicate which pages are replaced during faults.

in Measuring the problem information in input by S. Dobrev, R. Kralovic and D. Pardubská, *RAIRO-Theor. Inf. Appl.* 43 (2009) 585–613



A tree of $T(F, C)$.
Inductive computations
on clique-width- K graphs, by F. Carrere.
RAIRO-Theor. Inf. Appl. 43 (2009)
625–651

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